Reference No.: WTS13S0503306E

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FCC TEST REPORT

FCC ID	: ZBW-YPSIDE4					
Applicant	: SAFRAN MORPHO)				
Address	: 18, chaussée Jules Cesar OSNY France 95520					
Manufacturer : Taiguen Technology (ShenZhen) Co., Ltd. Address : NO.23,The Third Industrial Park of Xia village, Gongming, new District, Shenzhen City, Guangdong Province,P.R.Chi						
Equipment Under Test (EUT)	:					
Product Name	: ypsID Token					
Model No.	: ypsID E4					
Rules	: FCC CFR47 Part 15 Section 15.107:2010 FCC CFR47 Part 15 Section 15.109:2010					
Date of Test	: May 8~10, 2013					
Date of Issue	: May 22, 2013					
Test Result	: PASS *					
C63.4:2003. The test results ha their essential requirements.	ve been reviewed and port refer only to the s	in compliance with the requirements of ANSI domply with the rules listed above and found to mee ample(s) tested, this test report cannot be sion of the company.				
The report would be invalid with approver.	out specific stamp of t	est institute and the signatures of compiler and				
	Prepar	ed Bv:				
	Waltek Services (S	•				
1/F, Fukangtai E	•	Rd., Songgang Street, Baoan District,				
, ,	•	18105, China				
Tel: -	+86-755-83551033	Fax: +86-755-83552400				
Compiled by: Maibe	u. 2hang	Approved by: The should				
Maikou Zhang / Project Eng	ineer	Philo Zhong / Manager				

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2 Test Summary

Test Items	Test Requirement	Result
Conducted Emission	FCC Part 15.107:2010	PASS
Radiated Emission	FCC Part 15.109:2010	PASS

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4 General Information

4.1 General Description of E.U.T.

Product Name : ypsID Token

Model No. : ypsID E4

Operation Frequency : 13.56MHz
Oscillator :Crystal 8MHz

Antenna installation PCB Printed Antenna

4.2 Details of E.U.T.

Technical Data : DC 5V
Adapter : N/A

4.3 Description of Support Units

No.	Equipment	Manufacturer	Model No.	Serial No
1	Computer	Acer	Aspire AG1720	1300148096
2	LCD	Acer	AL1515	EFL240B217612002 1C391B
3	Keyboard	Shuangfeiyan	KB-3	-
4	Mouse	Shuangfeiyan	OP-220	-
5	Notebook	IBM	2672-39C	99-8D3W4

4.4 Test Facility

The test facility has a test site registered with the following organizations:

IC – Registration No.: 7760A

Waltek Services(Shenzhen) Co., Ltd. has been registered and fully described in a report filed with the Industry Canada. The acceptance letter from the Industry Canada is maintained in our files.

Registration 7760A, July 12, 2012.

• FCC – Registration No.: 880581

Waltek Services(Shenzhen) Co., Ltd. EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration 880581, May 26, 2011.

4.5 Test Location

All the tests were performed at:

Waltek Services(Shenzhen) Co., Ltd. at 1/F, Fukangtai Building, West Baima Rd., Songgang Street, Baoan District, Shenzhen, China

5 Equipment Used during Test

3m Semi-anechoic Chamber for Radiation(TDK)							
Item	Equipment	Manufacturer	Model No.	Serial No	Last Calibration Date	Calibration Due Date	
1	Test Receiver	R&S	ESCI	101296	Aug.09, 2012	Aug.08,2013	
2	Active Loop Antenna	Beijing Dazhi	ZN30900A	-	Aug. 13, 2012	Aug.12, 013	
3	Trilog Broadband Antenna	SCHWARZBECK	VULB9160	9160-3325	Apr.20, 2013	Apr.19, 2014	
4	Amplifier	Compliance pirection systems inc	PAP-0203	22024	Apr.07, 2013	Apr.06, 2014	
5	Cable	HUBER+SUHNE R	CBL2	525178	Sep.15, 2012	Sep.14, 2013	

5.1 Measurement Uncertainty

Parameter	Uncertainty
Radio Frequency	$\pm 1 \times 10^{-6}$
Bandwidth	$\pm 1.5 \times 10^{-6}$
RF Power	± 1.0 dB
RF Power Density	± 2.2 dB
Temperature	±1 °C
DC Source	±0.05%
	± 3.58 dB (9KH~30MHz)
Radiated Emissions test	± 5.03 dB (30M~1000MHz)
	± 4.74 dB (1000M~25000MHz)
Conducted Spurious	± 0.5 dB (9KHz~1000MHz)
Emissions test	± 1 dB(1000M~26500MHz)

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6 Conducted Emission Data

Test Requirement: FCC Part 15 Section 15.107

Test Method: ANSI C63.4:2003

Test Result: PASS

Frequency Range: 150kHz to 30MHz

Class: Class B

Limit: 66-56 dB_µV between 0.15MHz & 0.5MHz

56 dB μ V between 0.5MHz & 5MHz 60 dB μ V between 5MHz & 30MHz

The tighter limit applies at the band edges.

Detector: Peak for pre-scan (9kHz Resolution Bandwidth)

Quasi-Peak & Average if maximised peak within 6dB of

Average Limit

6.1 E.U.T. Operation

Operating Environment: Temperature: 25.5 °C

Humidity: 51 % RH

Atmospheric Pressure: 1012 mbar

EUT Operation:

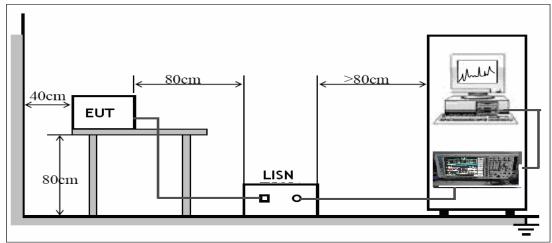
The test was performed on PC connecting mode.

The EUT was tested according to ANSI C63.4:2003. The frequency spectrum from 150kHz to 30MHz was investigated.

The maximised peak emissions from the EUT was scanned and measured for both the Live and Neutral Lines. Quasi-peak & average measurements were performed if peak emissions were within 6dB of the average limit line.

6.2 EUT Setup

The EUT was placed on the test table in shielding room.

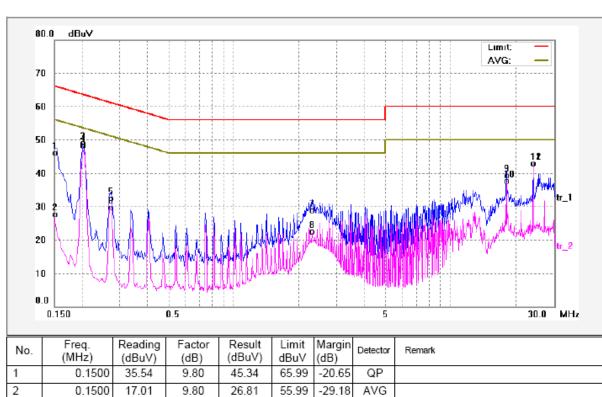


6.3 Conducted Emission Test Result

An initial pre-scan was performed on the live and neutral lines.

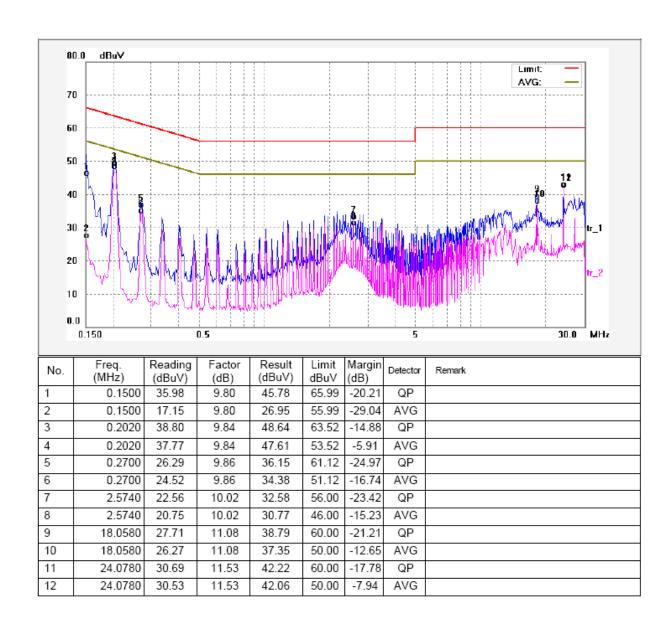
Test mode: working with PC

Live line:



No.	Freq. (MHz)	Reading (dBuV)	Factor (dB)	Result (dBuV)	Limit dBuV	Margin (dB)	Detector	Remark
<u> </u>	` '	. ,	٠, ,	` '		` '		
1	0.1500	35.54	9.80	45.34	65.99	-20.65	QP	
2	0.1500	17.01	9.80	26.81	55.99	-29.18	AVG	
3	0.2020	38.37	9.84	48.21	63.52	-15.31	QP	
4	0.2020	37.61	9.84	47.45	53.52	-6.07	AVG	
5	0.2740	21.87	9.86	31.73	60.99	-29.26	QP	
6	0.2740	19.06	9.86	28.92	50.99	-22.07	AVG	
7	2.3020	18.13	10.01	28.14	56.00	-27.86	QP	
8	2.3020	11.62	10.01	21.63	46.00	-24.37	AVG	
9	18.0580	27.33	11.08	38.41	60.00	-21.59	QP	
10	18.0580	25.79	11.08	36.87	50.00	-13.13	AVG	
11	24.0780	30.63	11.53	42.16	60.00	-17.84	QP	
12	24.0780	30.51	11.53	42.04	50.00	-7.96	AVG	

Neutral line:



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7 Radiation Emission Data

Test Requirement: FCC Part 15 Section 15.109

Test Method: ANSI C63.4:2003

Test Result: PASS

Frequency Range: 8MHz to 1GHz

Measurement Distance: 3m

Class: Class B

Limit: 40.0 dB_μV/m between 30MHz & 88MHz for Quasi-Peak

43.5 dB μ V/m between 88MHz & 216MHz for Quasi-Peak 46.0 dB μ V/m between 216MHz & 960MHz for Quasi-Peak

 $54.0 \text{ dB}_{\mu}\text{V/m}$ above 960MHz & 1GHz for Quasi-Peak

54.0 dBuV/m above 1GHz for AV 74.0 dBuV/m above 1GHz for Peak

The tighter limit applies at the band edges.

Detector: Peak for pre-scan (120kHz resolution bandwidth)

Quasi-Peak if maximised peak within 6dB of limit

7.1 E.U.T. Operation

Operating Environment:

Temperature: 25.5 °C

Humidity: 51 % RH

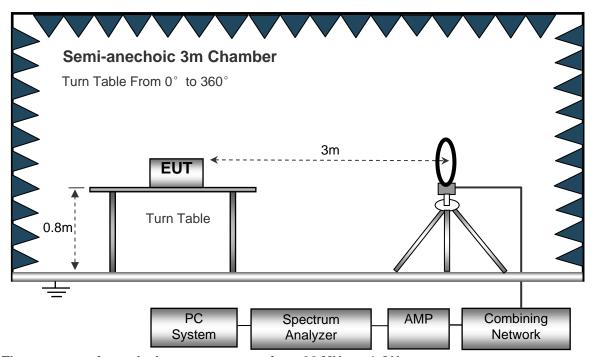
Atmospheric Pressure: 1012 mbar

EUT Operation:

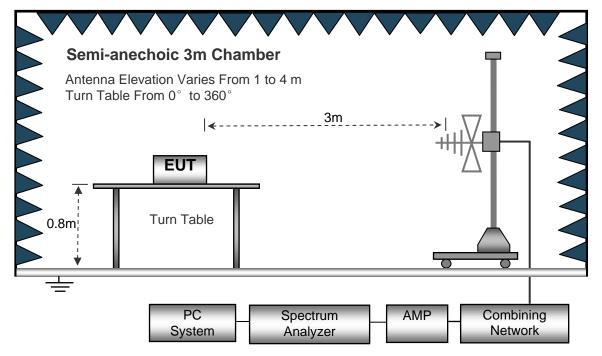
The pre-test was performed on PC connecting mode.

7.2 EUT Setup

The radiated emission tests were performed in the 3m Semi- Anechoic Chamber test site. The test setup for emission measurement below 30MHz.



The test setup for emission measurement from 30 MHz to 1 GHz.



7.3 Spectrum Analyzer Setup

According to FCC Part15 B Rules, the system was tested 8MHz to 1GHz.

Below 30MHz

Sweep Speed	Auto
IF Bandwidth	10KHz
Video Bandwidth	10KHz
Resolution Bandwidth	10KHz

30MHz ~ 1GHz

Sweep Speed	Auto
IF Bandwidth	120 KHz
Video Bandwidth	100KHz
Quasi-Peak Adapter Bandwidth	120 KHz
Quasi-Peak Adapter Mode	Normal
Resolution Bandwidth	100KHz

7.4 Test Procedure

- 1. The EUT is placed on a turntable, which is 0.8m above ground plane.
- 2. The turntable shall be rotated for 360 degrees to determine the position of maximum emission level.
- 3. EUT is set 3m away from the receiving antenna, which is moved from 1m to 4m to find out the maximum emissions.
- 4. Maximum procedure was performed on the six highest emissions to ensure EUT compliance.
- 5. And also, each emission was to be maximized by changing the polarization of receiving antenna both horizontal and vertical.
- 6. Repeat above procedures until the measurements for all frequencies are complete.
- 7. The radiation measurements are performed in X(normal uses) axis positioning.

7.5 Corrected Amplitude & Margin Calculation

The Corrected Amplitude is calculated by adding the Antenna Factor and Cable Factor, and subtracting the Amplifier Gain from the Amplitude reading. The basic equation is as follows:

Corr. Ampl. = Indicated Reading + Antenna Factor + Cable Factor - Amplifier Gain

The "Margin" column of the following data tables indicates the degree of compliance with the applicable limit. For example, a margin of -7dB μ V means the emission is 7dB μ V below the maximum limit for Class B. The equation for margin calculation is as follows:

Margin = Corr. Ampl. – Class B Limit

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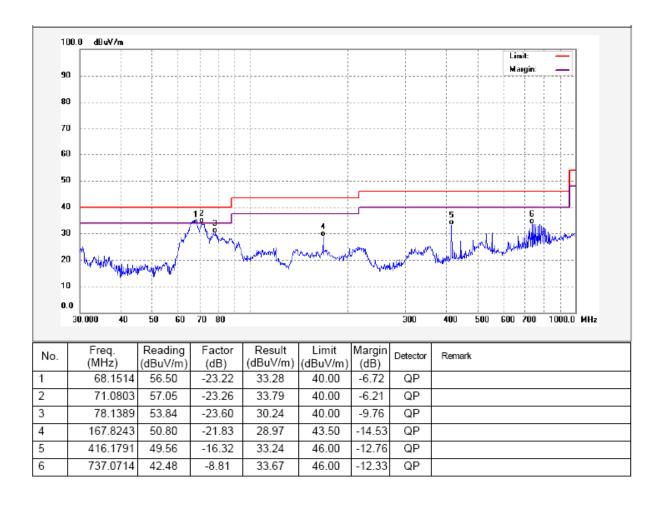
7.6 Summary of Test Results

Test Frequency: Below 30MHz

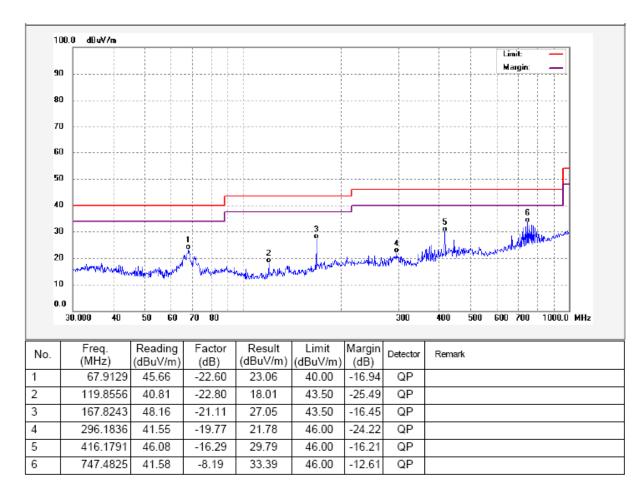
After pretest, we found no higher emission than background level. So the data is not shown in the test report.

Test Frequency: 30MHz ~ 1000MHz

Test mode: working with PC Antenna polarization: Vertical

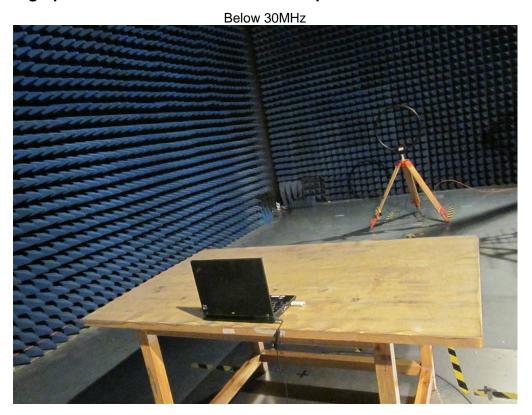


Antenna polarization: Horizontal



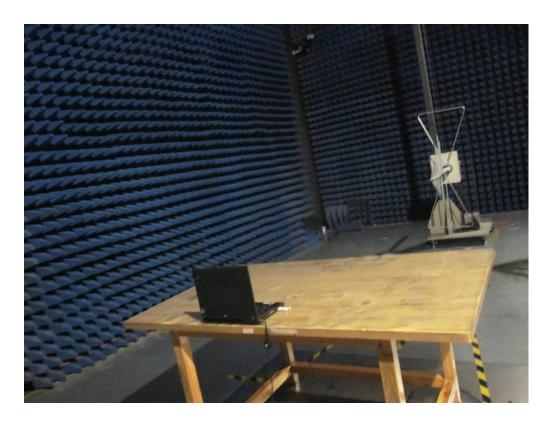
8 Photographs – Test Setup

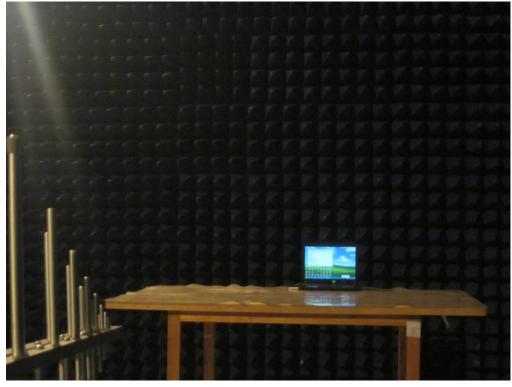
8.1 Photograph – Radiation Emission Test Setup





30MHz to 1GHz





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8.2 Photograph – Conducted Emission Test Setup



9 Photographs –Constructional Details

9.1 EUT - External View





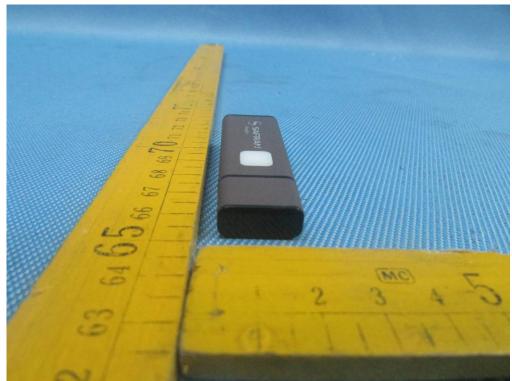
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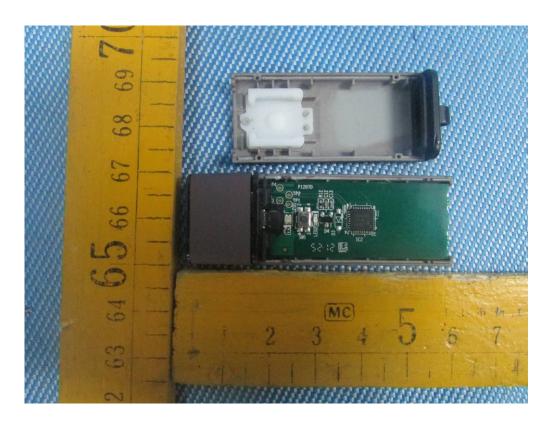


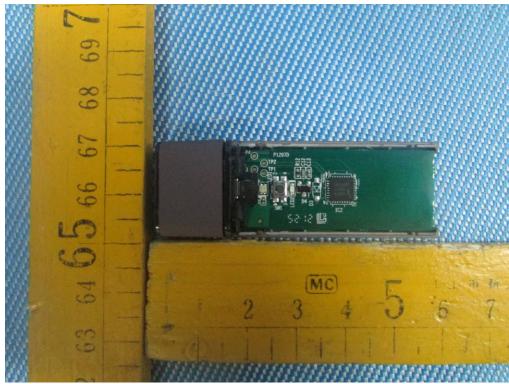
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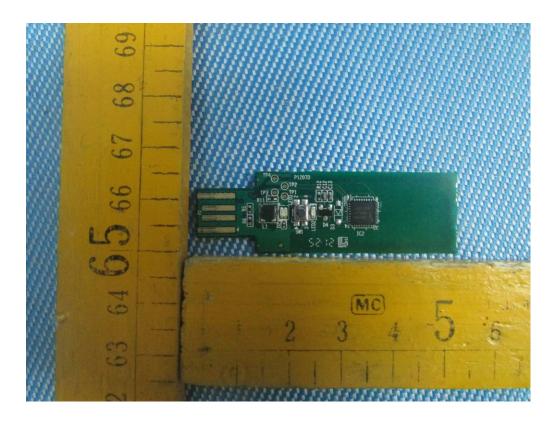


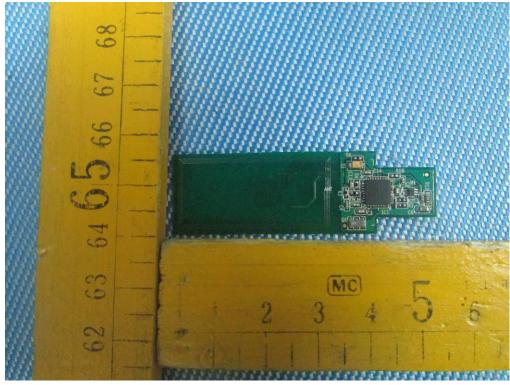


9.2 EUT - Internal View









==END==